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Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China





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DS099 (v3.0) October 29, 2012

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Spartan-3 FPGA Family: Introduction and Ordering Information

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Product Specification

Introduction

The Spartan®-3 family of Field-Programmable Gate Arrays is specifically designed to meet the needs of high volume, cost-sensitive consumer electronic applications. The eight-member family offers densities ranging from 50,000 to 5,000,000 system gates, as shown in [Table 1](#).

The Spartan-3 family builds on the success of the earlier Spartan-IIIE family by increasing the amount of logic resources, the capacity of internal RAM, the total number of I/Os, and the overall level of performance as well as by improving clock management functions. Numerous enhancements derive from the Virtex®-II platform technology. These Spartan-3 FPGA enhancements, combined with advanced process technology, deliver more functionality and bandwidth per dollar than was previously possible, setting new standards in the programmable logic industry.

Because of their exceptionally low cost, Spartan-3 FPGAs are ideally suited to a wide range of consumer electronics applications, including broadband access, home networking, display/projection and digital television equipment.

The Spartan-3 family is a superior alternative to mask programmed ASICs. FPGAs avoid the high initial cost, the lengthy development cycles, and the inherent inflexibility of conventional ASICs. Also, FPGA programmability permits design upgrades in the field with no hardware replacement necessary, an impossibility with ASICs.

Table 1: Summary of Spartan-3 FPGA Attributes

Device	System Gates	Equivalent Logic Cells ⁽¹⁾	CLB Array (One CLB = Four Slices)			Distributed RAM Bits (K=1024)	Block RAM Bits (K=1024)	Dedicated Multipliers	DCMs	Max. User I/O	Maximum Differential I/O Pairs
			Rows	Columns	Total CLBs						
XC3S50 ⁽²⁾	50K	1,728	16	12	192	12K	72K	4	2	124	56
XC3S200 ⁽²⁾	200K	4,320	24	20	480	30K	216K	12	4	173	76
XC3S400 ⁽²⁾	400K	8,064	32	28	896	56K	288K	16	4	264	116
XC3S1000 ⁽²⁾	1M	17,280	48	40	1,920	120K	432K	24	4	391	175
XC3S1500	1.5M	29,952	64	52	3,328	208K	576K	32	4	487	221
XC3S2000	2M	46,080	80	64	5,120	320K	720K	40	4	565	270
XC3S4000	4M	62,208	96	72	6,912	432K	1,728K	96	4	633	300
XC3S5000	5M	74,880	104	80	8,320	520K	1,872K	104	4	633	300

Notes:

- Logic Cell = 4-input Look-Up Table (LUT) plus a 'D' flip-flop. "Equivalent Logic Cells" equals "Total CLBs" x 8 Logic Cells/CLB x 1.125 effectiveness.
- These devices are available in Xilinx Automotive versions as described in [DS314: Spartan-3 Automotive XA FPGA Family](#).

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Features

- Low-cost, high-performance logic solution for high-volume, consumer-oriented applications
 - Densities up to 74,880 logic cells
- SelectIO™ interface signaling
 - Up to 633 I/O pins
 - 622+ Mb/s data transfer rate per I/O
 - 18 single-ended signal standards
 - 8 differential I/O standards including LVDS, RSDS
 - Termination by Digitally Controlled Impedance
 - Signal swing ranging from 1.14V to 3.465V
 - Double Data Rate (DDR) support
 - [DDR, DDR2 SDRAM support](#) up to 333 Mb/s
- Logic resources
 - Abundant logic cells with shift register capability
 - Wide, fast multiplexers
 - Fast look-ahead carry logic
 - Dedicated 18 x 18 multipliers
 - JTAG logic compatible with IEEE 1149.1/1532
- SelectRAM™ hierarchical memory
 - Up to 1,872 Kbits of total block RAM
 - Up to 520 Kbits of total distributed RAM
- Digital Clock Manager (up to four DCMs)
 - Clock skew elimination
 - Frequency synthesis
 - High resolution phase shifting
- Eight global clock lines and abundant routing
- Fully supported by [Xilinx ISE®](#) and [WebPACK™](#) software development systems
- [MicroBlaze™](#) and [PicoBlaze™](#) processor, [PCI®](#), [PCI Express® PIPE Endpoint](#), and other [IP cores](#)
- Pb-free packaging options
- Automotive [Spartan-3 XA Family](#) variant

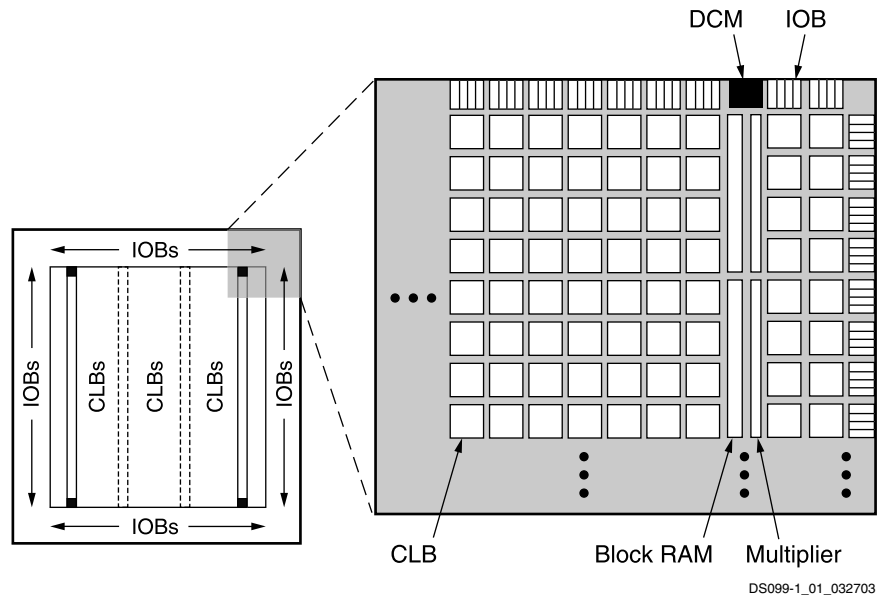
Architectural Overview

The Spartan-3 family architecture consists of five fundamental programmable functional elements:

- Configurable Logic Blocks (CLBs) contain RAM-based Look-Up Tables (LUTs) to implement logic and storage elements that can be used as flip-flops or latches. CLBs can be programmed to perform a wide variety of logical functions as well as to store data.
- Input/Output Blocks (IOBs) control the flow of data between the I/O pins and the internal logic of the device. Each IOB supports bidirectional data flow plus 3-state operation. Twenty-six different signal standards, including eight high-performance differential standards, are available as shown in Table 2. Double Data-Rate (DDR) registers are included. The Digitally Controlled Impedance (DCI) feature provides automatic on-chip terminations, simplifying board designs.
- Block RAM provides data storage in the form of 18-Kbit dual-port blocks.
- Multiplier blocks accept two 18-bit binary numbers as inputs and calculate the product.
- Digital Clock Manager (DCM) blocks provide self-calibrating, fully digital solutions for distributing, delaying, multiplying, dividing, and phase shifting clock signals.

These elements are organized as shown in Figure 1. A ring of IOBs surrounds a regular array of CLBs. The XC3S50 has a single column of block RAM embedded in the array. Those devices ranging from the XC3S200 to the XC3S2000 have two columns of block RAM. The XC3S4000 and XC3S5000 devices have four RAM columns. Each column is made up of several 18-Kbit RAM blocks; each block is associated with a dedicated multiplier. The DCMs are positioned at the ends of the outer block RAM columns.

The Spartan-3 family features a rich network of traces and switches that interconnect all five functional elements, transmitting signals among them. Each functional element has an associated switch matrix that permits multiple connections to the routing.



Notes:

1. The two additional block RAM columns of the XC3S4000 and XC3S5000 devices are shown with dashed lines. The XC3S50 has only the block RAM column on the far left.

Figure 1: Spartan-3 Family Architecture

Configuration

Spartan-3 FPGAs are programmed by loading configuration data into robust reprogrammable static CMOS configuration latches (CCLs) that collectively control all functional elements and routing resources. Before powering on the FPGA, configuration data is stored externally in a PROM or some other nonvolatile medium either on or off the board. After applying

power, the configuration data is written to the FPGA using any of five different modes: Master Parallel, Slave Parallel, Master Serial, Slave Serial, and Boundary Scan (JTAG). The Master and Slave Parallel modes use an 8-bit-wide SelectMAP port.

The recommended memory for storing the configuration data is the low-cost Xilinx Platform Flash PROM family, which includes the XCF00S PROMs for serial configuration and the higher density XCF00P PROMs for parallel or serial configuration.

I/O Capabilities

The SelectIO feature of Spartan-3 devices supports eighteen single-ended standards and eight differential standards as listed in Table 2. Many standards support the DCI feature, which uses integrated terminations to eliminate unwanted signal reflections.

Table 2: Signal Standards Supported by the Spartan-3 Family

Standard Category	Description	V _{CCO} (V)	Class	Symbol (IOSTANDARD)	DCI Option
Single-Ended					
GTL	Gunning Transceiver Logic	N/A	Terminated	GTL	Yes
			Plus	GTLP	Yes
HSTL	High-Speed Transceiver Logic	1.5	I	HSTL_I	Yes
			III	HSTL_III	Yes
		1.8	I	HSTL_I_18	Yes
			II	HSTL_II_18	Yes
III	HSTL_III_18	Yes			
LVCMOS	Low-Voltage CMOS	1.2	N/A	LVCMOS12	No
		1.5	N/A	LVCMOS15	Yes
		1.8	N/A	LVCMOS18	Yes
		2.5	N/A	LVCMOS25	Yes
		3.3	N/A	LVCMOS33	Yes
LVTTTL	Low-Voltage Transistor-Transistor Logic	3.3	N/A	LVTTTL	No
PCI	Peripheral Component Interconnect	3.0	33 MHz ⁽¹⁾	PCI33_3	No
SSTL	Stub Series Terminated Logic	1.8	N/A (±6.7 mA)	SSTL18_I	Yes
			N/A (±13.4 mA)	SSTL18_II	No
		2.5	I	SSTL2_I	Yes
			II	SSTL2_II	Yes
Differential					
LDT (ULVDS)	Lightning Data Transport (HyperTransport™) Logic	2.5	N/A	LDT_25	No
LVDS	Low-Voltage Differential Signaling		Standard	LVDS_25	Yes
			Bus	BLVDS_25	No
			Extended Mode	LVDSEXT_25	Yes
LVPECL	Low-Voltage Positive Emitter-Coupled Logic	2.5	N/A	LVPECL_25	No
RSDS	Reduced-Swing Differential Signaling	2.5	N/A	RSDS_25	No
HSTL	Differential High-Speed Transceiver Logic	1.8	II	DIFF_HSTL_II_18	Yes
SSTL	Differential Stub Series Terminated Logic	2.5	II	DIFF_SSTL2_II	Yes

Notes:

- 66 MHz PCI is not supported by the Xilinx IP core although PCI66_3 is an available I/O standard.

Table 3 shows the number of user I/Os as well as the number of differential I/O pairs available for each device/package combination.

Table 3: Spartan-3 Device I/O Chart

Available User I/Os and Differential (Diff) I/O Pairs by Package Type																				
Package	VQ100 VQG100		CP132 ⁽¹⁾ CPG132		TQ144 TQG144		PQ208 PQG208		FT256 FTG256		FG320 FGG320		FG456 FGG456		FG676 FGG676		FG900 FGG900		FG1156 ⁽¹⁾ FGG1156	
Footprint (mm)	16 x 16		8 x 8		22 x 22		30.6 x 30.6		17 x 17		19 x 19		23 x 23		27 x 27		31 x 31		35 x 35	
Device	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff
XC3S50	63	29	89 ⁽¹⁾	44 ⁽¹⁾	97	46	124	56	–	–	–	–	–	–	–	–	–	–	–	–
XC3S200	63	29	–	–	97	46	141	62	173	76	–	–	–	–	–	–	–	–	–	–
XC3S400	–	–	–	–	97	46	141	62	173	76	221	100	264	116	–	–	–	–	–	–
XC3S1000	–	–	–	–	–	–	–	–	173	76	221	100	333	149	391	175	–	–	–	–
XC3S1500	–	–	–	–	–	–	–	–	–	–	221	100	333	149	487	221	–	–	–	–
XC3S2000	–	–	–	–	–	–	–	–	–	–	–	–	333	149	489	221	565	270	–	–
XC3S4000	–	–	–	–	–	–	–	–	–	–	–	–	–	–	489	221	633	300	712 ⁽¹⁾	312 ⁽¹⁾
XC3S5000	–	–	–	–	–	–	–	–	–	–	–	–	–	–	489	221	633	300	784 ⁽¹⁾	344 ⁽¹⁾

Notes:

1. The CP132, CPG132, FG1156, and FGG1156 packages are discontinued. See http://www.xilinx.com/support/documentation/spartan-3_customer_notices.htm.
2. All device options listed in a given package column are pin-compatible.
3. User = Single-ended user I/O pins. Diff = Differential I/O pairs.

Package Marking

Figure 2 shows the top marking for Spartan-3 FPGAs in the quad-flat packages. Figure 3 shows the top marking for Spartan-3 FPGAs in BGA packages except the 132-ball chip-scale package (CP132 and CPG132). The markings for the BGA packages are nearly identical to those for the quad-flat packages, except that the marking is rotated with respect to the ball A1 indicator. Figure 4 shows the top marking for Spartan-3 FPGAs in the CP132 and CPG132 packages.

The “5C” and “4I” part combinations may be dual marked as “5C/4I”. Devices with the dual mark can be used as either -5C or -4I devices. Devices with a single mark are only guaranteed for the marked speed grade and temperature range. Some specifications vary according to mask revision. Mask revision E devices are errata-free. All shipments since 2006 have been mask revision E.

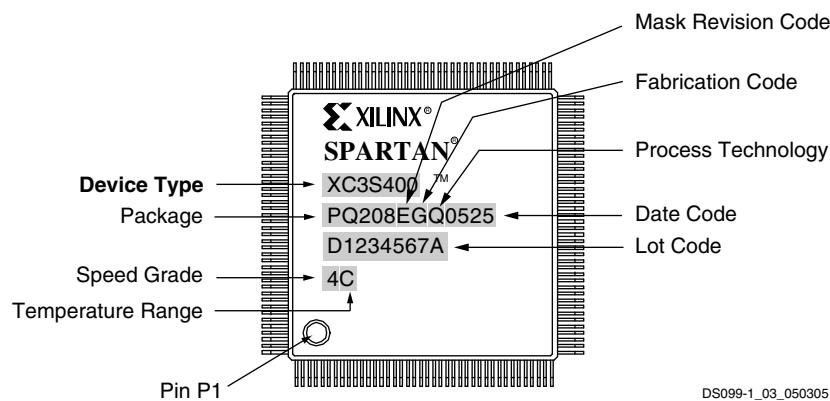
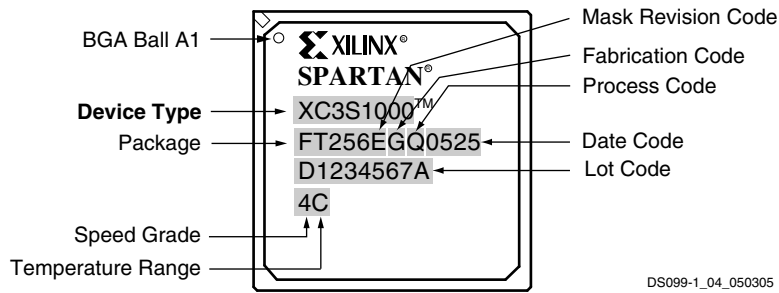
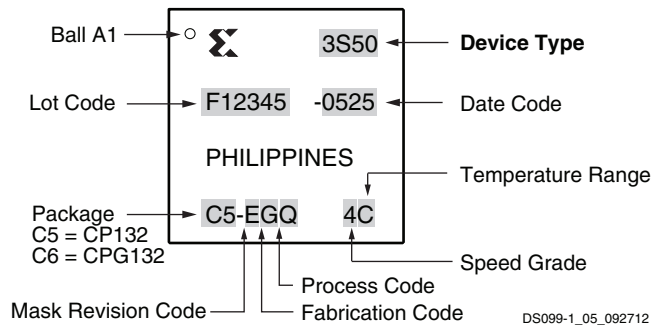


Figure 2: Spartan-3 FPGA QFP Package Marking Example for Part Number XC3S400-4PQ208C



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Figure 3: Spartan-3 FPGA BGA Package Marking Example for Part Number XC3S1000-4FT256C

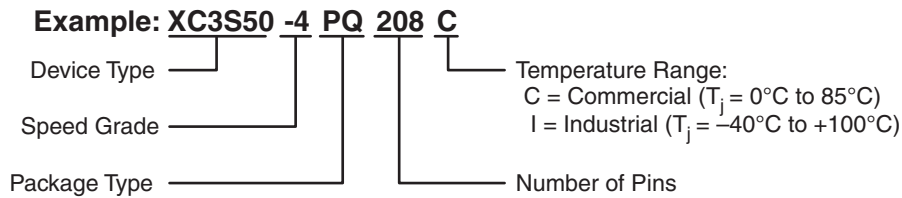


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Figure 4: Spartan-3 FPGA CP132 and CPG132 Package Marking Example for XC3S50-4CP132C

Ordering Information

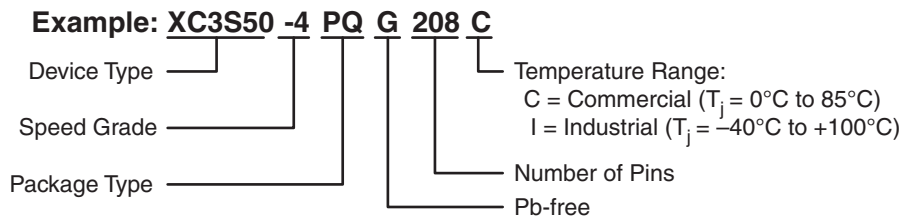
Spartan-3 FPGAs are available in both standard (Figure 5) and Pb-free (Figure 6) packaging options for all device/package combinations. The Pb-free packages include a special ‘G’ character in the ordering code.



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Figure 5: Standard Packaging

For additional information on Pb-free packaging, see [XAPP427: Implementation and Solder Reflow Guidelines for Pb-Free Packages](#).



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Figure 6: Pb-Free Packaging

Table 4: Example Ordering Information

Device	Speed Grade		Package Type/Number of Pins		Temperature Range (T _j)	
XC3S50	-4	Standard Performance	VQ(G)100	100-pin Very Thin Quad Flat Pack (VQFP)	C	Commercial (0°C to 85°C)
XC3S200	-5	High Performance ⁽¹⁾	CP(G)132 ⁽²⁾	132-pin Chip-Scale Package (CSP)	I	Industrial (-40°C to 100°C)
XC3S400			TQ(G)144	144-pin Thin Quad Flat Pack (TQFP)		
XC3S1000			PQ(G)208	208-pin Plastic Quad Flat Pack (PQFP)		
XC3S1500			FT(G)256	256-ball Fine-Pitch Thin Ball Grid Array (FTBGA)		
XC3S2000			FG(G)320	320-ball Fine-Pitch Ball Grid Array (FBGA)		
XC3S4000			FG(G)456	456-ball Fine-Pitch Ball Grid Array (FBGA)		
XC3S5000			FG(G)676	676-ball Fine-Pitch Ball Grid Array (FBGA)		
			FG(G)900	900-ball Fine-Pitch Ball Grid Array (FBGA)		
			FG(G)1156 ⁽²⁾	1156-ball Fine-Pitch Ball Grid Array (FBGA)		

Notes:

1. The -5 speed grade is exclusively available in the Commercial temperature range.
2. The CP132, CPG132, FG1156, and FGG1156 packages are discontinued. See http://www.xilinx.com/support/documentation/spartan-3_customer_notices.htm.

Revision History

Date	Version	Description
04/11/03	1.0	Initial Xilinx release.
04/24/03	1.1	Updated block RAM, DCM, and multiplier counts for the XC3S50.
12/24/03	1.2	Added the FG320 package.
07/13/04	1.3	Added information on Pb-free packaging options.
01/17/05	1.4	Referenced Spartan-3 XA Automotive FPGA families in Table 1. Added XC3S50CP132, XC3S2000FG456, XC3S4000FG676 options to Table 3. Updated Package Marking to show mask revision code, fabrication facility code, and process technology code.
08/19/05	1.5	Added package markings for BGA packages (Figure 3) and CP132/CPG132 packages (Figure 4). Added differential (complementary single-ended) HSTL and SSTL I/O standards.
04/03/06	2.0	Increased number of supported single-ended and differential I/O standards.
04/26/06	2.1	Updated document links.
05/25/07	2.2	Updated Package Marking to allow for dual-marking.
11/30/07	2.3	Added XC3S5000 FG(G)676 to Table 3. Noted that FG(G)1156 package is being discontinued and updated max I/O count.
06/25/08	2.4	Updated max I/O counts based on FG1156 discontinuation. Clarified dual mark in Package Marking. Updated formatting and links.
12/04/09	2.5	CP132 and CPG132 packages are being discontinued. Added link to Spartan-3 FPGA customer notices. Updated Table 3 with package footprint dimensions.
10/29/12	3.0	Added Notice of Disclaimer section. Per XCN07022, updated the discontinued FG1156 and FGG1156 package discussion throughout document. Per XCN08011, updated the discontinued CP132 and CPG132 package discussion throughout document. Although the package is discontinued, updated the marking on Figure 4. This product is not recommended for new designs.

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Spartan-3 FPGA Design Documentation

The functionality of the Spartan®-3 FPGA family is described in the following documents. The topics covered in each guide are listed.

- [UG331: Spartan-3 Generation FPGA User Guide](#)

- Clocking Resources
- Digital Clock Managers (DCMs)
- Block RAM
- Configurable Logic Blocks (CLBs)
 - Distributed RAM
 - SRL16 Shift Registers
 - Carry and Arithmetic Logic
- I/O Resources
- Embedded Multiplier Blocks
- Programmable Interconnect
- ISE® Software Design Tools
- IP Cores
- Embedded Processing and Control Solutions
- Pin Types and Package Overview
- Package Drawings
- Powering FPGAs

- [UG332: Spartan-3 Generation Configuration User Guide](#)

- Configuration Overview
 - Configuration Pins and Behavior
 - Bitstream Sizes
- Detailed Descriptions by Mode
 - Master Serial Mode using Xilinx Platform Flash PROM
 - Slave Parallel (SelectMAP) using a Processor
 - Slave Serial using a Processor
 - JTAG Mode
- ISE iMPACT Programming Examples

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For specific hardware examples, see the Spartan-3 FPGA Starter Kit board web page, which has links to various design examples and the user guide.

- Spartan-3 FPGA Starter Kit Board page
<http://www.xilinx.com/s3starter>
- [UG130: Spartan-3 FPGA Starter Kit User Guide](#)

IOBs

For additional information, refer to the chapter entitled “Using I/O Resources” in [UG331: Spartan-3 Generation FPGA User Guide](#).

IOB Overview

The Input/Output Block (IOB) provides a programmable, bidirectional interface between an I/O pin and the FPGA’s internal logic.

A simplified diagram of the IOB’s internal structure appears in [Figure 7](#). There are three main signal paths within the IOB: the output path, input path, and 3-state path. Each path has its own pair of storage elements that can act as either registers or latches. For more information, see the [Storage Element Functions](#) section. The three main signal paths are as follows:

- The input path carries data from the pad, which is bonded to a package pin, through an optional programmable delay element directly to the I line. There are alternate routes through a pair of storage elements to the IQ1 and IQ2 lines. The IOB outputs I, IQ1, and IQ2 all lead to the FPGA’s internal logic. The delay element can be set to ensure a hold time of zero.
- The output path, starting with the O1 and O2 lines, carries data from the FPGA’s internal logic through a multiplexer and then a three-state driver to the IOB pad. In addition to this direct path, the multiplexer provides the option to insert a pair of storage elements.
- The 3-state path determines when the output driver is high impedance. The T1 and T2 lines carry data from the FPGA’s internal logic through a multiplexer to the output driver. In addition to this direct path, the multiplexer provides the option to insert a pair of storage elements. When the T1 or T2 lines are asserted High, the output driver is high-impedance (floating, hi-Z). The output driver is active-Low enabled.
- All signal paths entering the IOB, including those associated with the storage elements, have an inverter option. Any inverter placed on these paths is automatically absorbed into the IOB.

Storage Element Functions

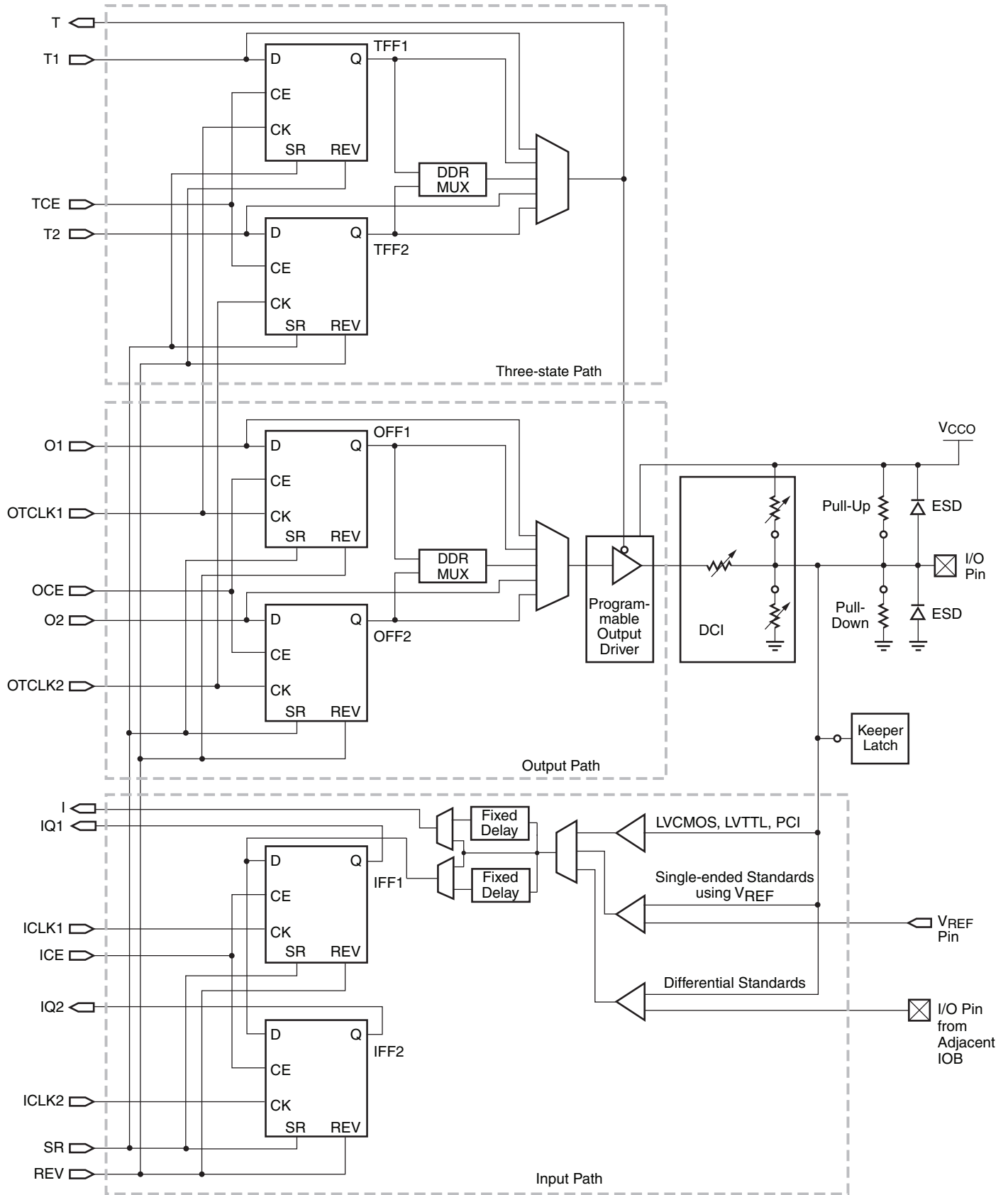
There are three pairs of storage elements in each IOB, one pair for each of the three paths. It is possible to configure each of these storage elements as an edge-triggered D-type flip-flop (FD) or a level-sensitive latch (LD).

The storage-element-pair on either the Output path or the Three-State path can be used together with a special multiplexer to produce Double-Data-Rate (DDR) transmission. This is accomplished by taking data synchronized to the clock signal’s rising edge and converting them to bits synchronized on both the rising and the falling edge. The combination of two registers and a multiplexer is referred to as a Double-Data-Rate D-type flip-flop (FDDR). See [Double-Data-Rate Transmission, page 12](#) for more information.

The signal paths associated with the storage element are described in [Table 5](#).

Table 5: Storage Element Signal Description

Storage Element Signal	Description	Function
D	Data input	Data at this input is stored on the active edge of CK enabled by CE. For latch operation when the input is enabled, data passes directly to the output Q.
Q	Data output	The data on this output reflects the state of the storage element. For operation as a latch in transparent mode, Q will mirror the data at D.
CK	Clock input	A signal’s active edge on this input with CE asserted, loads data into the storage element.
CE	Clock Enable input	When asserted, this input enables CK. If not connected, CE defaults to the asserted state.
SR	Set/Reset	Forces storage element into the state specified by the SRHIGH/SRLOW attributes. The SYNC/ASYN attribute setting determines if the SR input is synchronized to the clock or not.
REV	Reverse	Used together with SR. Forces storage element into the state opposite from what SR does.



Note: All IOB signals originating from the FPGA's internal logic have an optional polarity inverter.

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Figure 7: Simplified IOB Diagram

According to [Figure 7](#), the clock line OTCLK1 connects the CK inputs of the upper registers on the output and three-state paths. Similarly, OTCLK2 connects the CK inputs for the lower registers on the output and three-state paths. The upper and lower registers on the input path have independent clock lines: ICLK1 and ICLK2. The enable line OCE connects the CE inputs of the upper and lower registers on the output path. Similarly, TCE connects the CE inputs for the register pair on the three-state path and ICE does the same for the register pair on the input path. The Set/Reset (SR) line entering the IOB is common to all six registers, as is the Reverse (REV) line.

Each storage element supports numerous options in addition to the control over signal polarity described in the IOB Overview section. These are described in [Table 6](#).

Table 6: Storage Element Options

Option Switch	Function	Specificity
FF/Latch	Chooses between an edge-sensitive flip-flop or a level-sensitive latch	Independent for each storage element.
SYNC/ASYNC	Determines whether SR is synchronous or asynchronous	Independent for each storage element.
SRHIGH/SRLOW	Determines whether SR acts as a Set, which forces the storage element to a logic "1" (SRHIGH) or a Reset, which forces a logic "0" (SRLOW).	Independent for each storage element, except when using FDDR. In the latter case, the selection for the upper element (OFF1 or TFF2) applies to both elements.
INIT1/INIT0	In the event of a Global Set/Reset, after configuration or upon activation of the GSR net, this switch decides whether to set or reset a storage element. By default, choosing SRLOW also selects INIT0; choosing SRHIGH also selects INIT1.	Independent for each storage element, except when using FDDR. In the latter case, selecting INIT0 for one element applies to both elements (even though INIT1 is selected for the other).

Double-Data-Rate Transmission

Double-Data-Rate (DDR) transmission describes the technique of synchronizing signals to both the rising and falling edges of the clock signal. Spartan-3 devices use register-pairs in all three IOB paths to perform DDR operations.

The pair of storage elements on the IOB's Output path (OFF1 and OFF2), used as registers, combine with a special multiplexer to form a DDR D-type flip-flop (FDDR). This primitive permits DDR transmission where output data bits are synchronized to both the rising and falling edges of a clock. It is possible to access this function by placing either an FDDRSE or an FDDRCPE component or symbol into the design. DDR operation requires two clock signals (50% duty cycle), one the inverted form of the other. These signals trigger the two registers in alternating fashion, as shown in [Figure 8](#). Commonly, the Digital Clock Manager (DCM) generates the two clock signals by mirroring an incoming signal, then shifting it 180 degrees. This approach ensures minimal skew between the two signals.

The storage-element-pair on the Three-State path (TFF1 and TFF2) can also be combined with a local multiplexer to form an FDDR primitive. This permits synchronizing the output enable to both the rising and falling edges of a clock. This DDR operation is realized in the same way as for the output path.

The storage-element-pair on the input path (IFF1 and IFF2) allows an I/O to receive a DDR signal. An incoming DDR clock signal triggers one register and the inverted clock signal triggers the other register. In this way, the registers take turns capturing bits of the incoming DDR data signal.

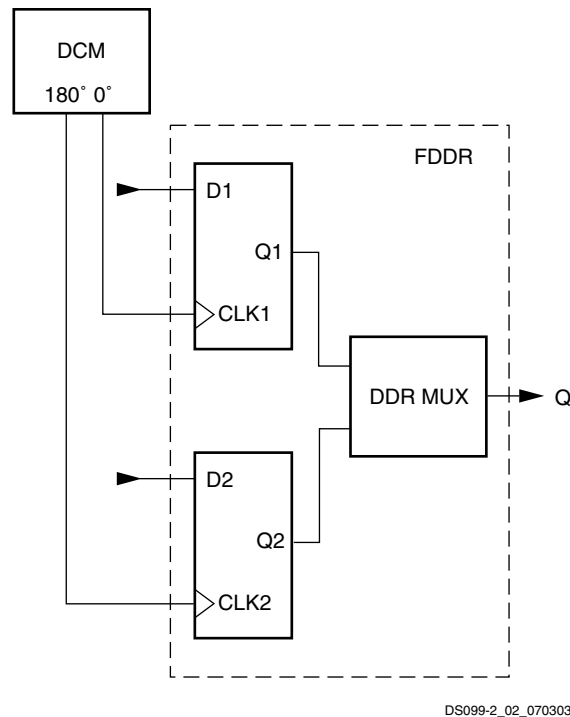


Figure 8: Clocking the DDR Register

Aside from high bandwidth data transfers, DDR can also be used to reproduce, or “mirror”, a clock signal on the output. This approach is used to transmit clock and data signals together. A similar approach is used to reproduce a clock signal at multiple outputs. The advantage for both approaches is that skew across the outputs will be minimal.

Some adjacent I/O blocks (IOBs) share common routing connecting the ICLK1, ICLK2, OTCLK1, and OTCLK2 clock inputs of both IOBs. These IOB pairs are identified by their differential pair names IO_LxxN_# and IO_LxxP_#, where “xx” is an I/O pair number and ‘#’ is an I/O bank number. Two adjacent IOBs containing DDR registers must share common clock inputs, otherwise one or more of the clock signals will be unroutable.

Pull-Up and Pull-Down Resistors

The optional pull-up and pull-down resistors are intended to establish High and Low levels, respectively, at unused I/Os. The pull-up resistor optionally connects each IOB pad to V_{CCO} . A pull-down resistor optionally connects each pad to GND. These resistors are placed in a design using the PULLUP and PULLDOWN symbols in a schematic, respectively. They can also be instantiated as components, set as constraints or passed as attributes in HDL code. These resistors can also be selected for all unused I/O using the Bitstream Generator (BitGen) option UnusedPin. A Low logic level on HSWAP_EN activates the pull-up resistors on all I/Os during configuration (see [The I/Os During Power-On, Configuration, and User Mode, page 21](#)).

The Spartan-3 FPGAs I/O pull-up and pull-down resistors are significantly stronger than the “weak” pull-up/pull-down resistors used in previous Xilinx FPGA families. See [Table 33, page 61](#) for equivalent resistor strengths.

Keeper Circuit

Each I/O has an optional keeper circuit that retains the last logic level on a line after all drivers have been turned off. This is useful to keep bus lines from floating when all connected drivers are in a high-impedance state. This function is placed in a design using the KEEPER symbol. Pull-up and pull-down resistors override the keeper circuit.

ESD Protection

Clamp diodes protect all device pads against damage from Electro-Static Discharge (ESD) as well as excessive voltage transients. Each I/O has two clamp diodes: One diode extends P-to-N from the pad to V_{CCO} and a second diode extends N-to-P from the pad to GND. During operation, these diodes are normally biased in the off state. These clamp diodes are always connected to the pad, regardless of the signal standard selected. The presence of diodes limits the ability of Spartan-3 FPGA I/Os to tolerate high signal voltages. The V_{IN} absolute maximum rating in [Table 28, page 58](#) specifies the voltage range that I/Os can tolerate.

Slew Rate Control and Drive Strength

Two options, FAST and SLOW, control the output slew rate. The FAST option supports output switching at a high rate. The SLOW option reduces bus transients. These options are only available when using one of the LVCMOS or LVTTTL standards, which also provide up to seven different levels of current drive strength: 2, 4, 6, 8, 12, 16, and 24 mA. Choosing the appropriate drive strength level is yet another means to minimize bus transients.

[Table 7](#) shows the drive strengths that the LVCMOS and LVTTTL standards support.

Table 7: Programmable Output Drive Current

Signal Standard (IOSTANDARD)	Current Drive (mA)						
	2	4	6	8	12	16	24
LVTTTL	✓	✓	✓	✓	✓	✓	✓
LVCMOS33	✓	✓	✓	✓	✓	✓	✓
LVCMOS25	✓	✓	✓	✓	✓	✓	✓
LVCMOS18	✓	✓	✓	✓	✓	✓	–
LVCMOS15	✓	✓	✓	✓	✓	–	–
LVCMOS12	✓	✓	✓	–	–	–	–

Boundary-Scan Capability

All Spartan-3 FPGA IOBs support boundary-scan testing compatible with IEEE 1149.1 standards. During boundary-scan operations such as EXTEST and HIGHZ the I/O pull-down resistor is active. For more information, see [Boundary-Scan \(JTAG\) Mode, page 50](#), and refer to the “Using Boundary-Scan and BSDL Files” chapter in [UG331](#).

SelectIO Interface Signal Standards

The IOBs support 18 different single-ended signal standards, as listed in [Table 8](#). Furthermore, the majority of IOBs can be used in specific pairs supporting any of eight differential signal standards, as shown in [Table 9](#).

To define the SelectIO™ interface signaling standard in a design, set the IOSTANDARD attribute to the appropriate setting. Xilinx provides a variety of different methods for applying the IOSTANDARD for maximum flexibility. For a full description of different methods of applying attributes to control IOSTANDARD, refer to the “Using I/O Resources” chapter in [UG331](#).

Together with placing the appropriate I/O symbol, two externally applied voltage levels, V_{CCO} and V_{REF} , select the desired signal standard. The V_{CCO} lines provide current to the output driver. The voltage on these lines determines the output voltage swing for all standards except GTL and GTLP.

All single-ended standards except the LVCMOS, LVTTTL, and PCI varieties require a Reference Voltage (V_{REF}) to bias the input-switching threshold. Once a configuration data file is loaded into the FPGA that calls for the I/Os of a given bank to use such a signal standard, a few specifically reserved I/O pins on the same bank automatically convert to V_{REF} inputs. When using one of the LVCMOS standards, these pins remain I/Os because the V_{CCO} voltage biases the input-switching threshold, so there is no need for V_{REF} . Select the V_{CCO} and V_{REF} levels to suit the desired single-ended standard according to [Table 8](#).

Table 8: Single-Ended I/O Standards

Signal Standard (IOSTANDARD)	V _{CCO} (Volts)		V _{REF} for Inputs (Volts) ⁽¹⁾	Board Termination Voltage (V _{TT}) in Volts
	For Outputs	For Inputs		
GTL	Note 2	Note 2	0.8	1.2
GTLP	Note 2	Note 2	1	1.5
HSTL_I	1.5	–	0.75	0.75
HSTL_III	1.5	–	0.9	1.5
HSTL_I_18	1.8	–	0.9	0.9
HSTL_II_18	1.8	–	0.9	0.9
HSTL_III_18	1.8	–	1.1	1.8
LVC MOS12	1.2	1.2	–	–
LVC MOS15	1.5	1.5	–	–
LVC MOS18	1.8	1.8	–	–
LVC MOS25	2.5	2.5	–	–
LVC MOS33	3.3	3.3	–	–
LVTTTL	3.3	3.3	–	–
PCI33_3	3.0	3.0	–	–
SSTL18_I	1.8	–	0.9	0.9
SSTL18_II	1.8	–	0.9	0.9
SSTL2_I	2.5	–	1.25	1.25
SSTL2_II	2.5	–	1.25	1.25

Notes:

1. Banks 4 and 5 of any Spartan-3 device in a VQ100 package do not support signal standards using V_{REF}.
2. The V_{CCO} level used for the GTL and GTLP standards must be no lower than the termination voltage (V_{TT}), nor can it be lower than the voltage at the I/O pad.
3. See Table 10 for a listing of the single-ended DCI standards.

Differential standards employ a pair of signals, one the opposite polarity of the other. The noise canceling (e.g., Common-Mode Rejection) properties of these standards permit exceptionally high data transfer rates. This section introduces the differential signaling capabilities of Spartan-3 devices.

Each device-package combination designates specific I/O pairs that are specially optimized to support differential standards. A unique “L-number”, part of the pin name, identifies the line-pairs associated with each bank (see Figure 40, page 112). For each pair, the letters ‘P’ and ‘N’ designate the true and inverted lines, respectively. For example, the pin names IO_L43P_7 and IO_L43N_7 indicate the true and inverted lines comprising the line pair L43 on Bank 7. The V_{CCO} lines provide current to the outputs. The V_{CCAUX} lines supply power to the differential inputs, making them independent of the V_{CCO} voltage for an I/O bank. The V_{REF} lines are not used. Select the V_{CCO} level to suit the desired differential standard according to Table 9.

Table 9: Differential I/O Standards

Signal Standard (IOSTANDARD)	V _{CCO} (Volts)		V _{REF} for Inputs (Volts)
	For Outputs	For Inputs	
LDT_25 (ULVDS_25)	2.5	–	–
LVDS_25	2.5	–	–
BLVDS_25	2.5	–	–
LVDSEXT_25	2.5	–	–
LVPECL_25	2.5	–	–
RSDS_25	2.5	–	–
DIFF_HSTL_II_18	1.8	–	–
DIFF_SSTL2_II	2.5	–	–

Notes:

1. See [Table 10](#) for a listing of the differential DCI standards.

The need to supply V_{REF} and V_{CCO} imposes constraints on which standards can be used in the same bank. See [The Organization of IOBs into Banks](#) section for additional guidelines concerning the use of the V_{CCO} and V_{REF} lines.

Digitally Controlled Impedance (DCI)

When the round-trip delay of an output signal—i.e., from output to input and back again—exceeds rise and fall times, it is common practice to add termination resistors to the line carrying the signal. These resistors effectively match the impedance of a device's I/O to the characteristic impedance of the transmission line, thereby preventing reflections that adversely affect signal integrity. However, with the high I/O counts supported by modern devices, adding resistors requires significantly more components and board area. Furthermore, for some packages—e.g., ball grid arrays—it may not always be possible to place resistors close to pins.

DCI answers these concerns by providing two kinds of on-chip terminations: Parallel terminations make use of an integrated resistor network. Series terminations result from controlling the impedance of output drivers. DCI actively adjusts both parallel and series terminations to accurately match the characteristic impedance of the transmission line. This adjustment process compensates for differences in I/O impedance that can result from normal variation in the ambient temperature, the supply voltage and the manufacturing process. When the output driver turns off, the series termination, by definition, approaches a very high impedance; in contrast, parallel termination resistors remain at the targeted values.

DCI is available only for certain I/O standards, as listed in [Table 10](#). DCI is selected by applying the appropriate I/O standard extensions to symbols or components. There are five basic ways to configure terminations, as shown in [Table 11](#). The DCI I/O standard determines which of these terminations is put into effect.

HSTL_I_DCI-, HSTL_III_DCI-, and SSTL2_I_DCI-type outputs do not require the VRN and VRP reference resistors. Likewise, LVDCI-type inputs do not require the VRN and VRP reference resistors. In a bank without any DCI I/O or a bank containing non-DCI I/O and purely HSTL_I_DCI- or HSTL_III_DCI-type outputs, or SSTL2_I_DCI-type outputs or LVDCI-type inputs, the associated VRN and VRP pins can be used as general-purpose I/O pins.

The HSLVDCI (High-Speed LVDCI) standard is intended for bidirectional use. The driver is identical to LVDCI, while the input is identical to HSTL. By using a V_{REF}-referenced input, HSLVDCI allows greater input sensitivity at the receiver than when using a single-ended LVCMOS-type receiver.

Table 10: DCI I/O Standards

Category of Signal Standard	Signal Standard (IOSTANDARD)	V _{CCO} (V)		V _{REF} for Inputs (V)	Termination Type	
		For Outputs	For Inputs		At Output	At Input
Single-Ended						
Gunning Transceiver Logic	GTL_DCI	1.2	1.2	0.8	Single	Single
	GTLP_DCI	1.5	1.5	1.0		
High-Speed Transceiver Logic	HSTL_I_DCI	1.5	1.5	0.75	None	Split
	HSTL_III_DCI	1.5	1.5	0.9	None	Single
	HSTL_I_DCI_18	1.8	1.8	0.9	None	Split
	HSTL_II_DCI_18 DIFF_HSTL_II_18_DCI	1.8	1.8	0.9	Split	
	HSTL_III_DCI_18	1.8	1.8	1.1	None	Single
Low-Voltage CMOS	LVDCI_15	1.5	1.5	–	Controlled impedance driver	None
	LVDCI_18	1.8	1.8	–		
	LVDCI_25	2.5	2.5	–		
	LVDCI_33 ⁽²⁾	3.3	3.3	–		
	LVDCI_DV2_15	1.5	1.5	–	Controlled driver with half-impedance	
	LVDCI_DV2_18	1.8	1.8	–		
	LVDCI_DV2_25	2.5	2.5	–		
	LVDCI_DV2_33	3.3	3.3	–		
Hybrid HSTL Input and LVCMOS Output	HSLVDCI_15	1.5	1.5	0.75	Controlled impedance driver	None
	HSLVDCI_18	1.8	1.8	0.9		
	HSLVDCI_25	2.5	2.5	1.25		
	HSLVDCI_33	3.3	3.3	1.65		
Stub Series Terminated Logic ⁽³⁾	SSTL18_I_DCI	1.8	1.8	0.9	25Ω driver	Split
	SSTL2_I_DCI	2.5	2.5	1.25	25Ω driver	
	SSTL2_II_DCI DIFF_SSTL2_II_DCI	2.5	2.5	1.25	Split with 25Ω driver	
Differential						
Low-Voltage Differential Signaling	LVDS_25_DCI	N/A	2.5	–	None	Split on each line of pair
	LVDS_25_DCI	N/A	2.5	–		

Notes:

- DCI signal standards are not supported in Bank 5 of any Spartan-3 FPGA packaged in a VQ100, CP132, or TQ144 package.
- Equivalent to LVTTTL DCI.
- The SSTL18_II signal standard does not have a DCI equivalent.

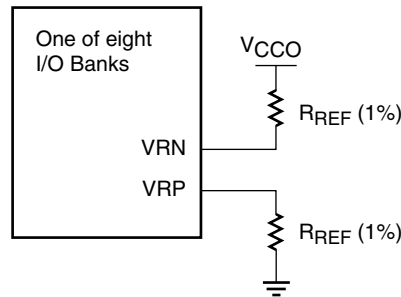
Table 11: DCI Terminations

Termination	Schematic ⁽¹⁾	Signal Standards (IOSTANDARD)
Controlled impedance output driver	<p style="text-align: right; font-size: small;">ds099_06a_070903</p>	LVDCI_15 LVDCI_18 LVDCI_25 LVDCI_33 HSLVDCI_15 HSLVDCI_18 HSLVDCI_25 HSLVDCI_33
Controlled output driver with half impedance	<p style="text-align: right; font-size: small;">ds099_06b_070903</p>	LVDCI_DV2_15 LVDCI_DV2_18 LVDCI_DV2_25 LVDCI_DV2_33
Single resistor	<p style="text-align: right; font-size: small;">ds099_06c_070903</p>	GTL_DCI GTLP_DCI HSTL_III_DCI ⁽²⁾ HSTL_III_DCI_18 ⁽²⁾
Split resistors	<p style="text-align: right; font-size: small;">ds099_06d_070903</p>	HSTL_I_DCI ⁽²⁾ HSTL_I_DCI_18 ⁽²⁾ HSTL_II_DCI_18 DIFF_HSTL_II_18_DCI DIFF_SSTL2_II_DCI LVDS_25_DCI LVDSEXT_25_DCI
Split resistors with output driver impedance fixed to 25Ω	<p style="text-align: right; font-size: small;">ds099_06e_070903</p>	SSTL18_I_DCI ⁽³⁾ SSTL2_I_DCI ⁽³⁾ SSTL2_II_DCI

Notes:

1. The value of R is equivalent to the characteristic impedance of the line connected to the I/O. It is also equal to half the value of RREF for the DV2 standards and RREF for all other DCI standards.
2. For DCI using HSTL Classes I and III, terminations only go into effect at inputs (not at outputs).
3. For DCI using SSTL Class I, the split termination only goes into effect at inputs (not at outputs).

The DCI feature operates independently for each of the device’s eight banks. Each bank has an ‘N’ reference pin, (VRN) and a ‘P’ reference pin, (VRP), to calibrate driver and termination resistance. Only when using a DCI standard on a given bank do these two pins function as VRN and VRP. When not using a DCI standard, the two pins function as user I/Os. As shown in [Figure 9](#), add an external reference resistor to pull the VRN pin up to V_{CCO} and another reference resistor to pull the VRP pin down to GND. Also see [Figure 42](#), [page 116](#). Both resistors have the same value—commonly 50Ω —with one-percent tolerance, which is either the characteristic impedance of the line or twice that, depending on the DCI standard in use. Standards having a symbol name that contains the letters “DV2” use a reference resistor value that is twice the line impedance. DCI adjusts the output driver impedance to match the reference resistors’ value or half that, according to the standard. DCI always adjusts the on-chip termination resistors to directly match the reference resistors’ value.



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Figure 9: Connection of Reference Resistors (R_{REF})

The rules guiding the use of DCI standards on banks are as follows:

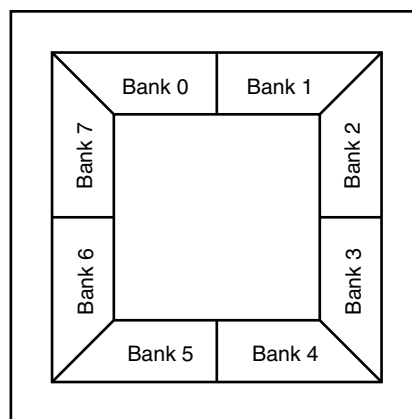
- No more than one DCI I/O standard with a Single Termination is allowed per bank.
- No more than one DCI I/O standard with a Split Termination is allowed per bank.
- Single Termination, Split Termination, Controlled- Impedance Driver, and Controlled-Impedance Driver with Half Impedance can co-exist in the same bank.

See also [The Organization of IOBs into Banks](#), immediately below, and [DCI: User I/O or Digitally Controlled Impedance Resistor Reference Input](#), [page 115](#).

The Organization of IOBs into Banks

IOBs are allocated among eight banks, so that each side of the device has two banks, as shown in [Figure 10](#). For all packages, each bank has independent V_{REF} lines. For example, V_{REF} Bank 3 lines are separate from the V_{REF} lines going to all other banks.

For the Very Thin Quad Flat Pack (VQ), Plastic Quad Flat Pack (PQ), Fine Pitch Thin Ball Grid Array (FT), and Fine Pitch Ball Grid Array (FG) packages, each bank has dedicated V_{CCO} lines. For example, the V_{CCO} Bank 7 lines are separate from the V_{CCO} lines going to all other banks. Thus, Spartan-3 devices in these packages support eight independent V_{CCO} supplies.



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Figure 10: Spartan-3 FPGA I/O Banks (Top View)

In contrast, the 144-pin Thin Quad Flat Pack (TQ144) package and the 132-pin Chip-Scale Package (CP132) tie V_{CCO} together internally for the pair of banks on each side of the device. For example, the V_{CCO} Bank 0 and the V_{CCO} Bank 1 lines are tied together. The interconnected bank-pairs are 0/1, 2/3, 4/5, and 6/7. As a result, Spartan-3 devices in the CP132 and TQ144 packages support four independent V_{CCO} supplies.

Note: The CP132 package is discontinued. See http://www.xilinx.com/support/documentation/spartan-3_customer_notices.htm.

Spartan-3 FPGA Compatibility

Within the Spartan-3 family, all devices are pin-compatible by package. When the need for future logic resources outgrows the capacity of the Spartan-3 device in current use, a larger device in the same package can serve as a direct replacement. Larger devices may add extra V_{REF} and V_{CCO} lines to support a greater number of I/Os. In the larger device, more pins can convert from user I/Os to V_{REF} lines. Also, additional V_{CCO} lines are bonded out to pins that were “not connected” in the smaller device. Thus, it is important to plan for future upgrades at the time of the board’s initial design by laying out connections to the extra pins.

The Spartan-3 family is not pin-compatible with any previous Xilinx FPGA family or with other platforms among the Spartan-3 Generation FPGAs.

Rules Concerning Banks

When assigning I/Os to banks, it is important to follow the following V_{CCO} rules:

- Leave no V_{CCO} pins unconnected on the FPGA.
- Set all V_{CCO} lines associated with the (interconnected) bank to the same voltage level.
- The V_{CCO} levels used by all standards assigned to the I/Os of the (interconnected) bank(s) must agree. The Xilinx development software checks for this. Tables 8, 9, and 10 describe how different standards use the V_{CCO} supply.
- Only one of the following standards is allowed on outputs per bank: LVDS, LDT, LVDS_EXT, or RSDS. This restriction is for the eight banks in each device, even if the V_{CCO} levels are shared across banks, as in the CP132 and TQ144 packages.
- If none of the standards assigned to the I/Os of the (interconnected) bank(s) uses V_{CCO} , tie all associated V_{CCO} lines to 2.5V.
- In general, apply 2.5V to V_{CCO} Bank 4 from power-on to the end of configuration. Apply the same voltage to V_{CCO} Bank 5 during parallel configuration or a Readback operation. For information on how to program the FPGA using 3.3V signals and power, see the [3.3V-Tolerant Configuration Interface](#) section.

If any of the standards assigned to the Inputs of the bank use V_{REF} then observe the following additional rules:

- Connect all V_{REF} pins within the bank to the same voltage level.
- The V_{REF} levels used by all standards assigned to the Inputs of the bank must agree. The Xilinx development software checks for this. Tables 8 and 10 describe how different standards use the V_{REF} supply.

If none of the standards assigned to the Inputs of a bank use V_{REF} for biasing input switching thresholds, all associated V_{REF} pins function as User I/Os.

Exceptions to Banks Supporting I/O Standards

Bank 5 of any Spartan-3 device in a VQ100, CP132, or TQ144 package does not support DCI signal standards. In this case, bank 5 has neither VRN nor VRP pins.

Furthermore, banks 4 and 5 of any Spartan-3 device in a VQ100 package do not support signal standards using V_{REF} (see [Table 8](#)). In this case, the two banks do not have any V_{REF} pins.

Supply Voltages for the IOBs

Three different supplies power the IOBs:

- The V_{CCO} supplies, one for each of the FPGA's I/O banks, power the output drivers, except when using the GTL and GTLP signal standards. The voltage on the V_{CCO} pins determines the voltage swing of the output signal.
- V_{CCINT} is the main power supply for the FPGA's internal logic.
- The V_{CCAUX} is an auxiliary source of power, primarily to optimize the performance of various FPGA functions such as I/O switching.

The I/Os During Power-On, Configuration, and User Mode

With no power applied to the FPGA, all I/Os are in a high-impedance state. The V_{CCINT} (1.2V), V_{CCAUX} (2.5V), and V_{CCO} supplies may be applied in any order. Before power-on can finish, V_{CCINT} , V_{CCO} Bank 4, and V_{CCAUX} must have reached their respective minimum recommended operating levels (see [Table 29, page 59](#)). At this time, all I/O drivers also will be in a high-impedance state. V_{CCO} Bank 4, V_{CCINT} , and V_{CCAUX} serve as inputs to the internal Power-On Reset circuit (POR).

A Low level applied to the HSWAP_EN input enables pull-up resistors on User I/Os from power-on throughout configuration. A High level on HSWAP_EN disables the pull-up resistors, allowing the I/Os to float. If the HSWAP_EN pin is floating, then an internal pull-up resistor pulls HSWAP_EN High. As soon as power is applied, the FPGA begins initializing its configuration memory. At the same time, the FPGA internally asserts the Global Set-Reset (GSR), which asynchronously resets all IOB storage elements to a Low state.

Upon the completion of initialization, INIT_B goes High, sampling the M0, M1, and M2 inputs to determine the configuration mode. At this point, the configuration data is loaded into the FPGA. The I/O drivers remain in a high-impedance state (with or without pull-up resistors, as determined by the HSWAP_EN input) throughout configuration.

The Global Three State (GTS) net is released during Start-Up, marking the end of configuration and the beginning of design operation in the User mode. At this point, those I/Os to which signals have been assigned go active while all unused I/Os remain in a high-impedance state. The release of the GSR net, also part of Start-up, leaves the IOB registers in a Low state by default, unless the loaded design reverses the polarity of their respective RS inputs.

In User mode, all internal pull-up resistors on the I/Os are disabled and HSWAP_EN becomes a “don't care” input. If it is desirable to have pull-up or pull-down resistors on I/Os carrying signals, the appropriate symbol—e.g., PULLUP, PULLDOWN—must be placed at the appropriate pads in the design. The Bitstream Generator (Bitgen) option UnusedPin available in the Xilinx development software determines whether unused I/Os collectively have pull-up resistors, pull-down resistors, or no resistors in User mode.

CLB Overview

For more details on the CLBs, refer to the chapter entitled “Using Configurable Logic Blocks” in [UG331](#).

The Configurable Logic Blocks (CLBs) constitute the main logic resource for implementing synchronous as well as combinatorial circuits. Each CLB comprises four interconnected slices, as shown in [Figure 11](#). These slices are grouped in pairs. Each pair is organized as a column with an independent carry chain.

The nomenclature that the FPGA Editor—part of the Xilinx development software—uses to designate slices is as follows: The letter 'X' followed by a number identifies columns of slices. The 'X' number counts up in sequence from the left side of the die to the right. The letter 'Y' followed by a number identifies the position of each slice in a pair as well as indicating the CLB row. The 'Y' number counts slices starting from the bottom of the die according to the sequence: 0, 1, 0, 1 (the first CLB row); 2, 3, 2, 3 (the second CLB row); etc. [Figure 11](#) shows the CLB located in the lower left-hand corner of the die. Slices X0Y0 and X0Y1 make up the column-pair on the left where as slices X1Y0 and X1Y1 make up the column-pair on the right. For each CLB, the term “left-hand” (or SLICEM) indicates the pair of slices labeled with an even 'X' number, such as X0, and the term “right-hand” (or SLICEL) designates the pair of slices with an odd 'X' number, e.g., X1.

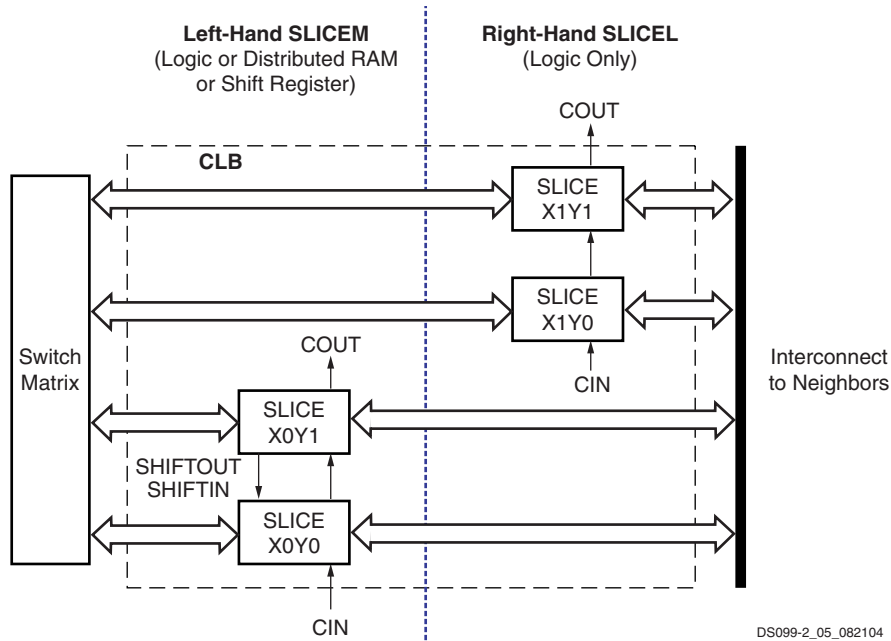


Figure 11: Arrangement of Slices within the CLB

Elements Within a Slice

All four slices have the following elements in common: two logic function generators, two storage elements, wide-function multiplexers, carry logic, and arithmetic gates, as shown in [Figure 12, page 24](#). Both the left-hand and right-hand slice pairs use these elements to provide logic, arithmetic, and ROM functions. Besides these, the left-hand pair supports two additional functions: storing data using Distributed RAM and shifting data with 16-bit registers. [Figure 12](#) is a diagram of the left-hand slice; therefore, it represents a superset of the elements and connections to be found in all slices. See [Function Generator, page 25](#) for more information.

The RAM-based function generator—also known as a Look-Up Table or LUT—is the main resource for implementing logic functions. Furthermore, the LUTs in each left-hand slice pair can be configured as Distributed RAM or a 16-bit shift register. For information on the former, refer to the chapter entitled “Using Look-Up Tables as Distributed RAM” in [UG331](#); for information on the latter, refer to the chapter entitled “Using Look-Up Tables as Shift Registers” in [UG331](#). The function generators located in the upper and lower portions of the slice are referred to as the “G” and “F”, respectively.

The storage element, which is programmable as either a D-type flip-flop or a level-sensitive latch, provides a means for synchronizing data to a clock signal, among other uses. The storage elements in the upper and lower portions of the slice are called FFY and FFX, respectively.

Wide-function multiplexers effectively combine LUTs in order to permit more complex logic operations. Each slice has two of these multiplexers with F5MUX in the lower portion of the slice and F1MUX in the upper portion. Depending on the slice, F1MUX takes on the name F6MUX, F7MUX, or F8MUX. For more details on the multiplexers, refer to the chapter entitled “Using Dedicated Multiplexers” in [UG331](#).

The carry chain, together with various dedicated arithmetic logic gates, support fast and efficient implementations of math operations. The carry chain enters the slice as CIN and exits as COUT. Five multiplexers control the chain: CYINIT, CY0F, and CYMUXF in the lower portion as well as CY0G and CYMUXG in the upper portion. The dedicated arithmetic logic includes the exclusive-OR gates XORG and XORF (upper and lower portions of the slice, respectively) as well as the AND gates GAND and FAND (upper and lower portions, respectively). For more details on the carry logic, refer to the chapter entitled “Using Carry and Arithmetic Logic” in [UG331](#).

Main Logic Paths

Central to the operation of each slice are two nearly identical data paths, distinguished using the terms *top* and *bottom*. The description that follows uses names associated with the bottom path. (The top path names appear in parentheses.) The basic path originates at an interconnect-switch matrix outside the CLB. Four lines, F1 through F4 (or G1 through G4 on the

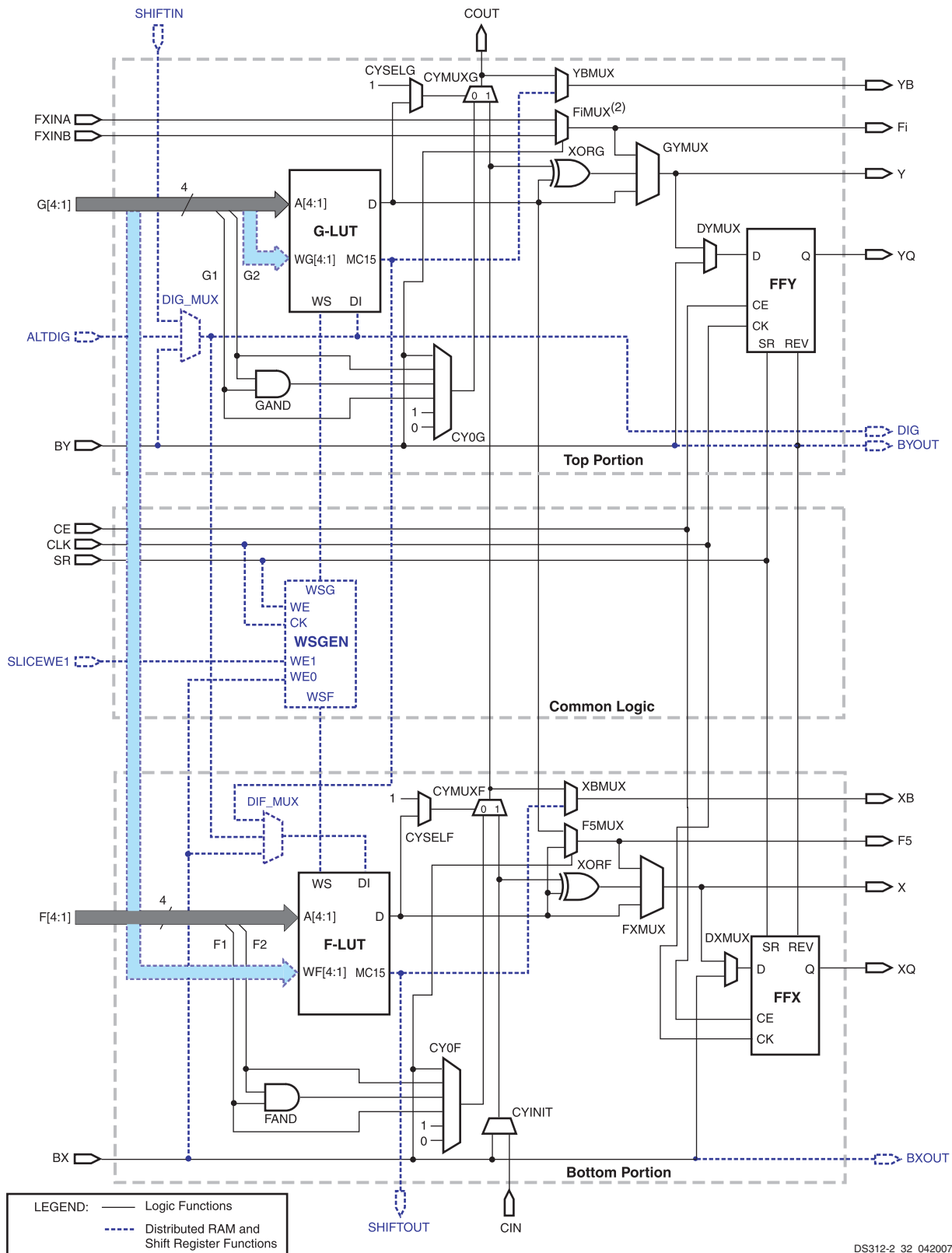
upper path), enter the slice and connect directly to the LUT. Once inside the slice, the lower 4-bit path passes through a function generator 'F' (or 'G') that performs logic operations. The function generator's Data output, 'D', offers five possible paths:

- Exit the slice via line 'X' (or 'Y') and return to interconnect.
- Inside the slice, 'X' (or 'Y') serves as an input to the DXMUX (DYMUX) which feeds the data input, 'D', of the FFX (FFY) storage element. The 'Q' output of the storage element drives the line XQ (or YQ) which exits the slice.
- Control the CYMUXF (or CYMUXG) multiplexer on the carry chain.
- With the carry chain, serve as an input to the XORF (or XORG) exclusive-OR gate that performs arithmetic operations, producing a result on 'X' (or 'Y').
- Drive the multiplexer F5MUX to implement logic functions wider than four bits. The 'D' outputs of both the F-LUT and G-LUT serve as data inputs to this multiplexer.

In addition to the main logic paths described above, there are two bypass paths that enter the slice as BX and BY. Once inside the FPGA, BX in the bottom half of the slice (or BY in the top half) can take any of several possible branches:

- Bypass both the LUT and the storage element, then exit the slice as BXOUT (or BYOUT) and return to interconnect.
- Bypass the LUT, then pass through a storage element via the D input before exiting as XQ (or YQ).
- Control the wide function multiplexer F5MUX (or F6MUX).
- Via multiplexers, serve as an input to the carry chain.
- Drives the DI input of the LUT.
- BY can control the REV inputs of both the FFY and FFX storage elements.
- Finally, the DIG_MUX multiplexer can switch BY onto the DIG line, which exits the slice.

Other slice signals shown in [Figure 12](#) are discussed in the sections that follow.



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Notes:

- Options to invert signal polarity as well as other options that enable lines for various functions are not shown.
- The index *i* can be 6, 7, or 8, depending on the slice. In this position, the upper right-hand slice has an F8MUX, and the upper left-hand slice has an F7MUX. The lower right-hand and left-hand slices both have an F6MUX.

Figure 12: Simplified Diagram of the Left-Hand SLICEM

Function Generator

Each of the two LUTs (F and G) in a slice have four logic inputs (A1-A4) and a single output (D). This permits any four-variable Boolean logic operation to be programmed into them. Furthermore, wide function multiplexers can be used to effectively combine LUTs within the same CLB or across different CLBs, making logic functions with still more input variables possible.

The LUTs in both the right-hand and left-hand slice-pairs not only support the logic functions described above, but also can function as ROM that is initialized with data at the time of configuration.

The LUTs in the left-hand slice-pair (even-numbered columns such as X0 in [Figure 11](#)) of each CLB support two additional functions that the right-hand slice-pair (odd-numbered columns such as X1) do not.

First, it is possible to program the “left-hand LUTs” as distributed RAM. This type of memory affords moderate amounts of data buffering anywhere along a data path. One left-hand LUT stores 16 bits. Multiple left-hand LUTs can be combined in various ways to store larger amounts of data. A dual port option combines two LUTs so that memory access is possible from two independent data lines. A Distributed ROM option permits pre-loading the memory with data during FPGA configuration.

Second, it is possible to program each left-hand LUT as a 16-bit shift register. Used in this way, each LUT can delay serial data anywhere from one to 16 clock cycles. The four left-hand LUTs of a single CLB can be combined to produce delays up to 64 clock cycles. The SHIFTIN and SHIFTOUT lines cascade LUTs to form larger shift registers. It is also possible to combine shift registers across more than one CLB. The resulting programmable delays can be used to balance the timing of data pipelines.

Block RAM Overview

All Spartan-3 devices support block RAM, which is organized as configurable, synchronous 18Kbit blocks. Block RAM stores relatively large amounts of data more efficiently than the distributed RAM feature described earlier. (The latter is better suited for buffering small amounts of data anywhere along signal paths.) This section describes basic Block RAM functions. For more information, refer to the chapter entitled “Using Block RAM” in [UG331](#).

The aspect ratio—i.e., width vs. depth—of each block RAM is configurable. Furthermore, multiple blocks can be cascaded to create still wider and/or deeper memories.

A choice among primitives determines whether the block RAM functions as dual- or single-port memory. A name of the form RAMB16_S[w_A][w_B] calls out the dual-port primitive, where the integers w_A and w_B specify the total data path width at ports w_A and w_B, respectively. Thus, a RAMB16_S9_S18 is a dual-port RAM with a 9-bit-wide Port A and an 18-bit-wide Port B. A name of the form RAMB16_S[w] identifies the single-port primitive, where the integer w specifies the total data path width of the lone port. A RAMB16_S18 is a single-port RAM with an 18-bit-wide port. Other memory functions—e.g., FIFOs, data path width conversion, ROM, etc.—are readily available using the CORE Generator™ software, part of the Xilinx development software.